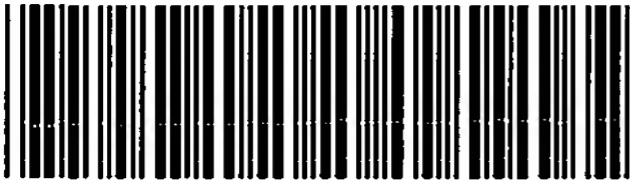


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/633,946	BOSTICK, JOHN W.	
	Examiner	Art Unit	
	Navneet Sonia Khaira	3754	

SEARCHED			
Class	Subclass	Date	Examiner
222	402.15, 174,167, 403.13,	2/11/2005	NK
222	164	2/11/2005	NK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR